Search Notes

Application/Control No.	App Ree
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Applicant(s)/Patent under
Reexamination

09/926,811

Examiner

David A. Vanore

FUNAKOSHI ET AL.

2881

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East Search (USPAT,USPGPUB,IBM,JPO,EPO,DE RWENT) Inventor search (text limited) Text search (see history)	12/27/2005	DAV
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